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Application/Control No.	Applicant(s)/Patent under Reexamination
10/764,755	LIOU, TIAN-AN
Examiner	Art Unit

	Reexamination
10/764,755	LIOU, TIAN-AN
Examiner	Art Unit
Anthony Stashick	3728

	SEARCHED		
Class	Subclass	Date	Examiner
36	3R, 3A, 3B, 141, 29, 35B	9/26/2005	ADS
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INTERFERENCE SEARCHED			
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